Notice of References	Cited
----------------------	-------

Application/Control No.	Applicant(s)/Patent Under	
10/567,244	Reexamination MEYER ET AL.	
Examiner	Art Unit	
SHIN KIM	3611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,197,600	03-1993	Garcia, Felix D.	206/308.3
*	В	US-7,185,690	03-2007	Johansson et al.	160/24
*	С	US-3,018,824	01-1962	ANDERSON JAMES A; et. al.	160/394
*	D	US-6,876,493	04-2005	Lin, Hsin-Fu	359/461
*	Е	US-4,520,583	06-1985	Oka, Takashi	40/378
*	F	US-7,337,822	03-2008	Snyder et al.	160/23.1
*	G	US-2,755,578	07-1956	GLACIUS GEORGE W	40/500
*	Н	US-4,458,739	07-1984	Murray et al.	160/23.1
*	Т	US-5,798,861	08-1998	Doat, Guy	359/461
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	***************************************			
	v				
	w				
	x				

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.